



FPD Metrology Korea TC Chapter Meeting Summary and Minutes

Korea Standards Winter Meetings

Thursday, January 15, 2026

2:00 PM – 4:00 PM (KST)

SEMI Korea office, Seoul / OVTCCM (hybrid)

TC Chapter Announcements

Next TC Chapter Meeting

September 10, 2026, OVTCCM.

Table 1 Meeting Attendees

Italics indicate virtual participants

Co-Chairs: Jaehong Kim (LG Display), Yongwoo Yi (Samsung Display)

SEMI Staff: Natalie Shim, Cindy Bae (SEMI Korea)

<i>Company</i>	<i>Last</i>	<i>First</i>	<i>Company</i>	<i>Last</i>	<i>First</i>
LG Display	Jeong	Jongho	Samsung Display	Yi	Yongwoo
<i>LG Display</i>	<i>Kim</i>	<i>Jae Hong</i>	SEMI Korea	Bae	Cindy
Samsung Display	Lee	Seungmin	SEMI Korea	Shim	Natalie

Table 2 Leadership Changes

<i>WG/TF/SC/TC Name</i>	<i>Previous Leader</i>	<i>New Leader</i>
None		

Table 3 TC Chapter Structure Changes

<i>Previous WG/TF/SC Name</i>	<i>New WG/TF/SC Name or Status Change</i>
None	

Table 4 Ballot Results

<i>Document #</i>	<i>Document Title</i>	<i>Committee Action</i>
7154B	New Standard, Test Method for Flicker of Flat Panel Displays	Failed and rework
7155	New Standard, Test Method for Optical Switchable Properties of Automotive Display	Failed and rework

#1 **Passed** ballots and line items will be submitted to the ISC Audit & Review Subcommittee for procedural review.

#2 **Failed** ballots and line items were returned to the originating task forces for re-work and re-balloting or abandoning.



Table 5 Ratification Ballot Results

<i>Document #</i>	<i>Document Title</i>	<i>Committee Action</i>	<i>A&R Forms for Approved Ballots</i>
None			

Note 1: **Passed** Ratification ballots will be submitted to SEMI publication for final processing.

Note 2: **Failed** Ratification ballots were returned to the originating task forces for re-work and re-balloting or abandoning.

Table 6 Activities Approved by the GCS between meetings of the TC Chapter

<i>#</i>	<i>Type</i>	<i>SC/TF/WG</i>	<i>Details</i>
None			

Table 7 Authorized Activities

Listing of all revised or new SNARF(s) approved by the Originating TC Chapter.

<i>#</i>	<i>Type</i>	<i>SC/TF/WG</i>	<i>Details</i>
None			

#1 SNARFs and TFOFs are available for review on the SEMI Web site at:

<http://downloads.semi.org/web/wstdsbal.nsf/TFOFSNARF>

Table 8 Authorized Ballots

<i>#</i>	<i>When</i>	<i>TF</i>	<i>Details</i>
7154C	Cycle 4, 2026	Picture Quality Evaluation TF	New Standard, Test Method for Flicker of Flat Panel Displays
7394	Cycle 4, 2026	Picture Quality Evaluation TF	New Standard, Test Method for Accurate Color Performance of Flat Panel Display
7155A	Cycle 6, 2026	Automotive Display TF	New Standard, Test Method for Optical Switchable Properties of Automotive Display

Table 9 SNARF(s) Granted a One-Year Extension

<i>#</i>	<i>TF</i>	<i>Title</i>	<i>Expiration Date</i>
None			

Table 10 SNARF(s) Cancelled

<i>#</i>	<i>TF</i>	<i>Title</i>
None		

Table 11 Standard(s) to receive Inactive Status

<i>Standard Designation</i>	<i>Title</i>
None	



Table 12 New Action Items

<i>Item #</i>	<i>Assigned to</i>	<i>Details</i>
2026-0115-1	Picture Quality Evaluation TF	Review the drafts of 7154C and 7394 from March 3 to March 10, 2026. The documents will be proceeded for ballot Cycle 4.
2026-0115-2	Automotive Display TF	Review the drafts of 7155A from June 2 to June 9, 2026. The documents will be proceeded for ballot Cycle 6.

Table 13 Previous Meeting Action Items

<i>Item #</i>	<i>Assigned to</i>	<i>Details</i>
2025-0911-1	Yongwoo Yi, Jaehong Kim	Revise D61-1110 and D61-0723 as requested by CIE. (Completed)
2025-0911-2	Natalie Shim	Report the status of copyright assessment to SEMI Headquarters via email. (Completed)

1 Welcome, Reminders, and Introductions

Yongwoo Yi (Samsung Display) called the meeting to order at 14:00 AM. The meeting reminders on antitrust issues, intellectual property issues, and holding meetings with international attendance were reviewed. Attendees introduced themselves.

- Attachment:**
1. Required Meeting Elements March 2024
 2. FPDM_Agenda_Jan15_2026

2 Review of Previous Meeting Minutes

Motion:	Approve the minutes as written
By/2nd:	Jongho Jeong (LG Display) / SeungMin Lee(Samsung Display)
Discussion:	None
Vote:	3-Y 0-N. Motion passed.

- Attachment:** 3. FPD Metrology TC Meeting Minutes_Aug 28_2025_v2

3 Liaison Reports

3.1 FPD Metrology Japan TC Chapter

Cindy Bae (SEMI Korea) reported for the FPD Metrology Japan TC Chapter. Of note:

3.1.1 Meeting Information

- Last Meeting: October 15, 2025, Hybrid
- Next Meeting: March 19, 2026, Hybrid

3.1.2 Ballot Results

- None

3.1.3 Please find the attached file for details of TF activities.

Attachment: 4. FPD Met_JA_Liaison Report_Jan 2026_R1

3.2 FPD Metrology Taiwan TC Chapter

Cindy Bae (SEMI Korea) reported for the FPD Metrology Taiwan TC Chapter. Of note:

3.2.1 Meeting Information

- Last Meeting: October 3, 2025, Hybrid
- Next Meeting: May 22, 2026, Hybrid

3.2.2 Ballot Results

- None

3.2.3 Authorized Activities

3.2.3.1 The following four SNARFs for Reapproval Ballots due to 5-year review were approved by the TC Chapter.

- Reapproval of SEMI D69-0520, Test Method of FPD-Based Stereoscopic Display with Active Glasses
- Reapproval of SEMI D70-0520, Test Method of FPD-Based Stereoscopic Display with Passive Glasses
- Reapproval of SEMI D72-0520, Test Method for Color Properties of Electronic Paper Displays
- Reapproval of SEMI D73-1020, Reapproval of SEMI D73-1020 - Test Method for Positional Accuracy of Capacitive Touchscreen Panel

3.2.4 Authorized Ballots

- Doc. 7352 — Major Revision to SEMI D056-00-0519 Test Method for Measurement for Ambient Contrast of Flat Panel Displays, was approved by the TC Chapter to proceed for ballot in Cycle 9, 2025.

3.2.5 Please find the attached file for details of TF activities.

Attachment: 5. FPD-M Taiwan Liaison Report_20251003_V1

3.3 SEMI Staff Report

Cindy Bae (SEMI Korea) gave the SEMI Staff Report. Of note:

3.3.1 SEMICON Upcoming Events

- SEMICON Korea: February 11-13, Seoul
- SEMICON China: March 25-27, Shanghai
- SEMICON Southeast Asia: May 5-7, Kuala Lumpur

3.3.2 Critical Dates for SEMI Standards Ballots

- See <https://www.semi.org/en/Standards/Ballots>

3.3.3 All SEMI Standards Task Forces shall use Connected@SEMI for managing TF activities and storing documents.

Attachment: 6. Staff_HQ Report Nov 2025 v5

4 Ballot Review

None

5 Subcommittee and Task Force Reports

5.1 Automotive Display Task Force

- Doc. 7155 — New Standard, Test Method for Optical Switchable Properties of Automotive Display failed. TF plans to submit ballot authorization of Doc. 7155A for cycle 6.

Motion:	Negative is related and persuasive.
Reason:	Better expression
By/2nd:	Jae Hong Kim (LG Display)/Jongho Jeong (LG Display)
Discussion:	
Vote:	3-Y 0-N, Motion carried

Motion:	Authorize the Document for Letter Ballot 7155A in cycle 6, 2026
By/2nd:	Jae Hong Kim (LG Display)/Jongho Jeong (LG Display)
Discussion:	The draft will be uploaded on Connect@SEMI by June 2. It will undergo one-week review by the TF members from June 2 to June 9. Feedback will be discussed during the TF meeting scheduled for June 12 (tentative).
Vote:	3-Y 0-N, Motion carried

Attachment: 7. A&R 7155_Failed

8. Attachment of A&R 7155 Rejects_SEMI DD 7155 - Comment from Yoshi Shibahara 20250905

5.2 Picture Quality Evaluation Task Force

- Doc. 7154B — New Standard, Test Method for Flicker of Flat Panel Displays failed. TF plans to submit ballot authorization of Doc. 7154C for cycle 4.

Motion:	Negative is related and persuasive.
Reason:	Better expression
By/2nd:	SeungMin Lee (Samsung Display)/Jongho Jeong (LG Display)

Discussion:	
Vote:	3-Y 0-N, Motion carried

Motion:	Authorize the Document for Letter Ballot 7154C in cycle 4, 2026
By/2nd:	SeungMin Lee (Samsung Display)/Jongho Jeong (LG Display)
Discussion:	The draft will be uploaded on Connect@SEMI by March 3. It will undergo one-week review by the TF members from March 3 to March 10. Feedback will be discussed during the TF meeting scheduled for March 13 (tentative). The finalized draft for the ballot will be submitted by March 16.
Vote:	3-Y 0-N, Motion carried

Attachment: 9. A&R 7154B_Failed

- SNARF 7394 — New Standard, Test Method for Accurate Color Performance of Flat Panel Display was authorized for Letter Ballot 7394 in cycle 4, 2026.

Motion:	Authorize the Document for Letter Ballot 7394 in Cycle 4, 2026
By/2nd:	Jae Hong Kim (LG Display)/SeungMin Lee (Samsung Display)
Discussion:	The draft will be uploaded on Connect@SEMI by March 3. It will undergo one-week review by the TF members from March 3 to March 10. Feedback will be discussed during the TF meeting scheduled for March 13 (tentative). The finalized draft for the ballot will be submitted by March 16.
Vote:	3-Y 0-N, Motion carried

6 Old Business

6.1 D61 Copyright Assessment

6.1.1 D61-1110 and D61-0723 will be revised as CIE requested. The documents underwent a two-stage review by the co-chairs, and the revised documents will be forwarded to SEMI HQ for publication. The committee decided to handle the CIECAM revisions via the standards revision process, as they are unrelated to the copyright issues.

7 New Business

None



8 Next Meeting and Adjournment

The next meeting is scheduled for Thursday, September 10, 2026, via OVTCCM. See <http://www.semi.org/standards-events> for the current list of events.

Adjournment: 16:00 PM.

Respectfully submitted by:

Cindy Bae

Coordinator

SEMI Korea

Phone: 82.2.531.7899

Email: sbae@semi.org

Minutes tentatively approved by:

Jaehong Kim (LG Display), Co-chair	<Date approved>
Yongwoo Yi (Samsung Display), Co-chair	<Date approved>

Table 14 Index of Available Attachments^{#1}

<i>Title</i>	<i>Title</i>
1. Required Meeting Elements March 2024	6. Staff_HQ Report Nov 2025 v5
2. FPD_M_Agenda_Jan15_2026	7. A&R 7155_Failed
3. FPD Metrology TC Meeting Minutes_Aug 28_2025_v2	8. Attachment of A&R 7155 Rejects_SEMI DD 7155 - Comment from Yoshi Shibahara 20250905
4. FPD Met_JA_Liaison Report_Jan 2026_R1	9. A&R 7154B_Failed
5. FPD-M Taiwan Liaison Report_20251003_V1	

^{#1} Due to file size and delivery issues, attachments must be downloaded separately. A .zip file containing all attachments for these minutes is available at www.semi.org. For additional information or to obtain individual attachments, please contact [SEMI Staff Name] at the contact information above.